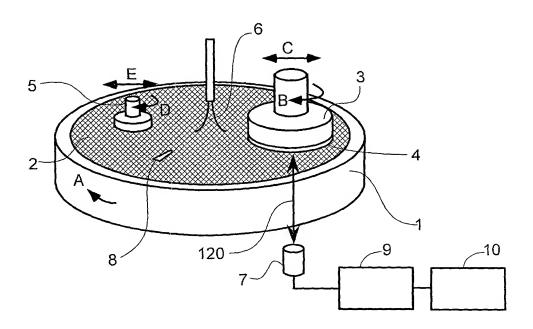
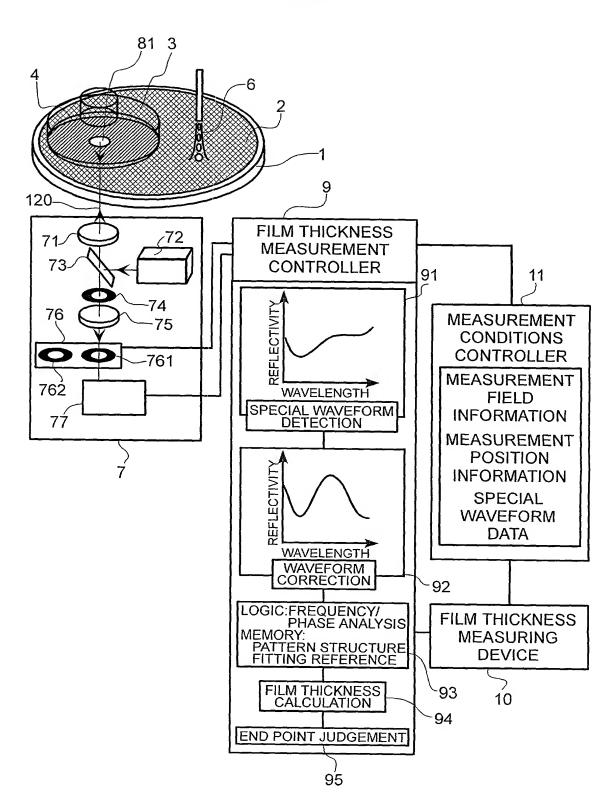
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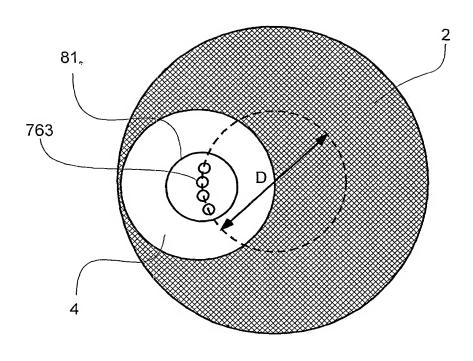
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FIG.3



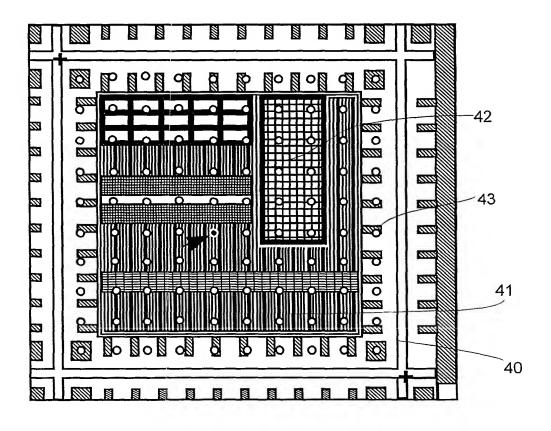
Applicant: Mineo Nomoto, et al.

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FIG.4



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FIG.5

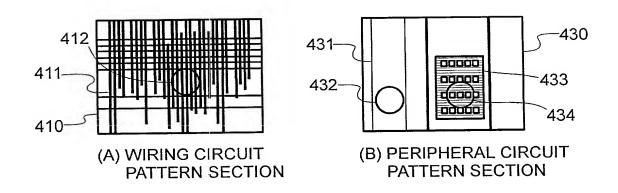


FIG.6

63
62
600
61

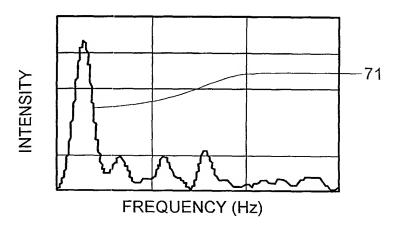
400
500
600
700
800
WAVELENGTH (nm)

Title: Method and Apparatus for Measuring Thickness of Thin Film...

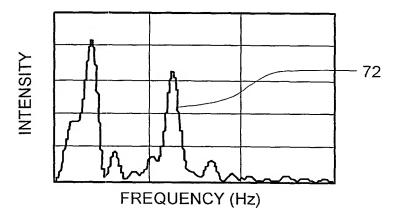
Atty Docket No. 16869P-041700

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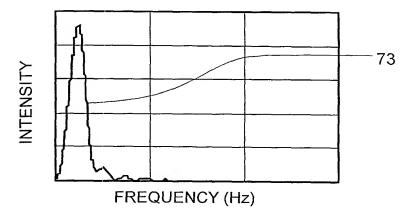
FIG.7



(a) WIRING CIRCUIT SECTION



(b) MEMORY CIRCUIT SECTION



(c) PERIPHERAL CIRCUIT SECTION

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FIG.8

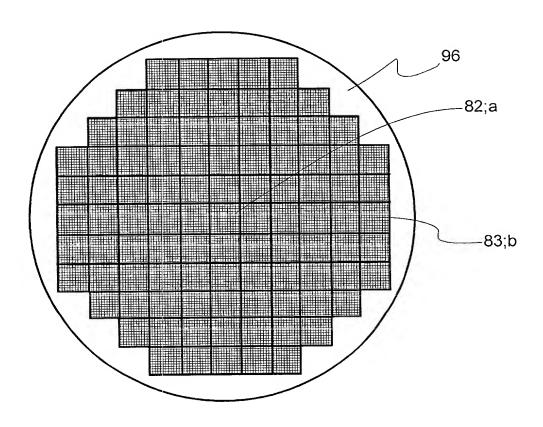
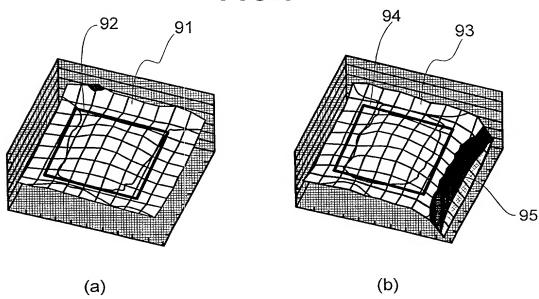
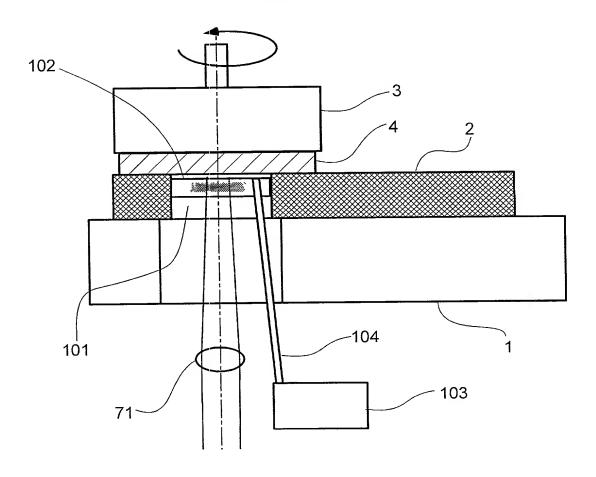


FIG.9



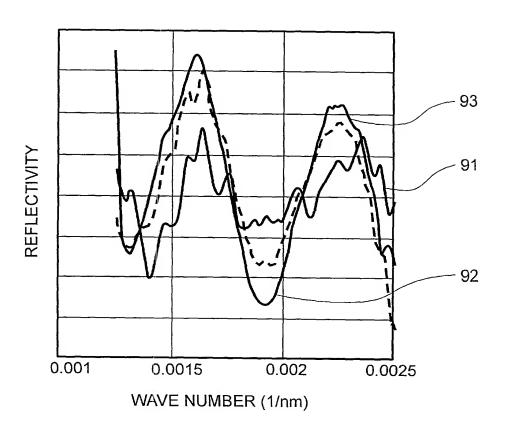
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FIG.10



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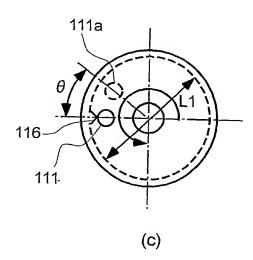


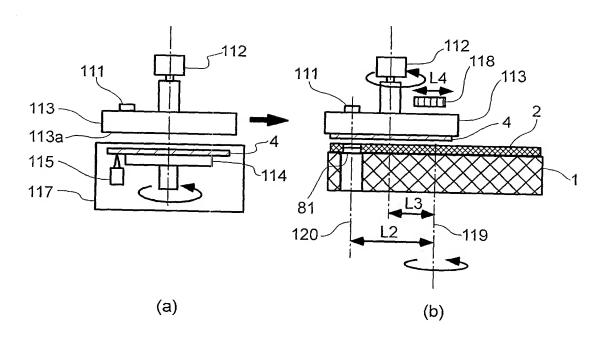
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FIG.12





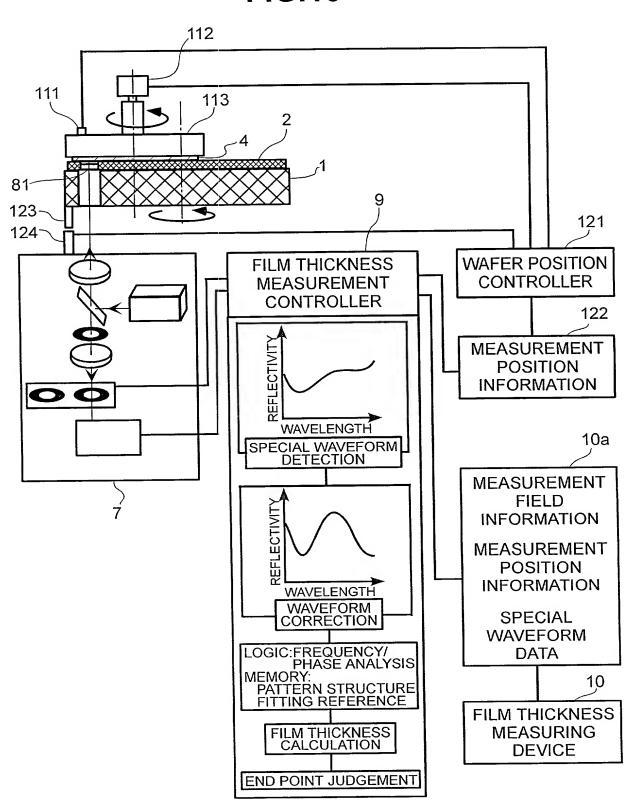
Applicant: Mineo Nomoto, et al.

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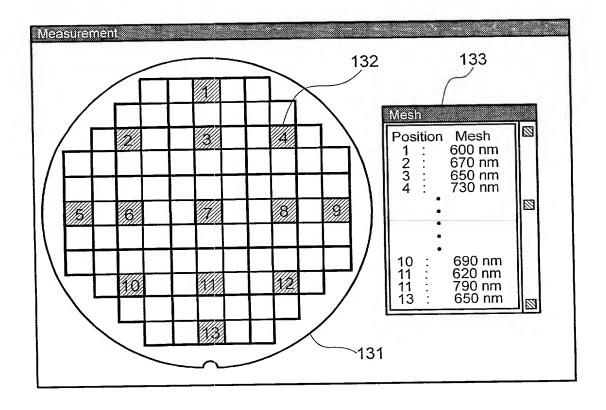
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FIG.13



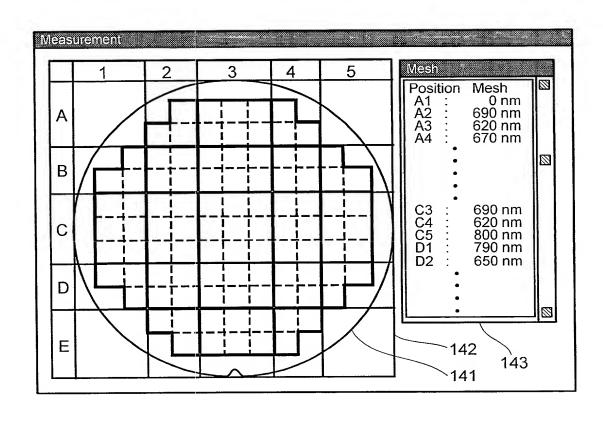
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FIG.14



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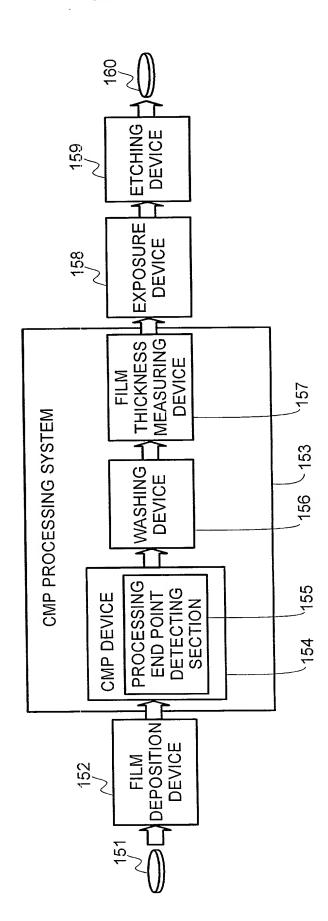


FIG. 16

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